Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/014,428	OHTA, SEIYA	
Examiner	Art Unit	

2612

Chriss S. Yoder, III

SEARCHED			
Class	Subclass	Date	Examiner
348	208.99 208.1 208.2 208.3 208.4	1/4/2005	СҮ
348	208.5	1/4/2005	CY
348	208.16	1/4/2005	CY
348	220.1	1/4/2005	CY
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
East Search History Included	1/4/2005	СҮ
Spoke with Yogesh Aggarwal	1/4/2005	СҮ
Spoke with Ngoc-Yen Vu	1/4/2005	СУ